Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination HAYASHI, MORIHIKO	
09/762,424		
Examiner	Art Unit	
Kevin Mew	2664	

SEARCHED					
Class	Subclass	Date	Examiner		
370	431	11/7/05	MEW		
370	320				
370	321				
370	322				
370	341				
370	346				
370	347				
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370	437				
370	442				
370	443				
370	447				
370	458				
370	461				
370	462	. 4	1		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examine	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East	11/7/05 11/13/05	MEW		